

Feature

- High Precision GaAs process
- High performance, shielded
- ullet GaAs substrate, 50Ω CPW output
- Au wire bonding, for MCM applications

Environmental Specifications

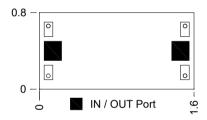
| Operating Temperature | -55℃~+85℃ | |
|-----------------------|------------|--|
| Storage Temperature | -65℃~+150℃ | |
| Max. Input Power | 30dBm | |

Electrical Specifications($T_A = +25$ °C)

| Parameter | Min. | Тур. | Max. | Unit |
|---------------------|--------------------|---------|------|------|
| Pass band | - | 33 ~ 41 | i | GHz |
| Insertion Loss @ fc | - | ı | 2.3 | dB |
| Return Loss | 10 | ı | i | dB |
| Out of band | ≥40dB@100M ~ 21GHz | | | dB |
| Attenuation | | | | |

S2P file name: BWHF-33G.s2p

Outline Drawing

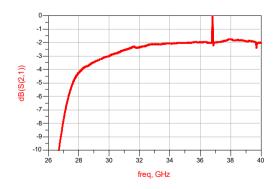


Notes:

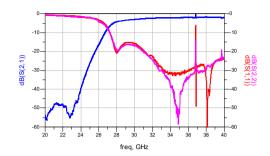
- 1. Dimensions are in millimeters. Tolerance: ±0.05mm
- 2. Die thickness is 0.1mm
- 3. Typical bond pad is 0.1x0.1 mm².
- 4. The bottom of the device is gold plated, should be grounded.

Typical Te5st Curves

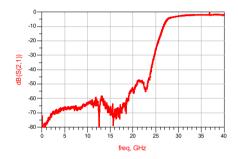
Insertion Loss VS Frequency (T_A=25°C)



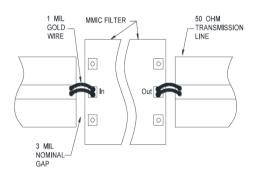
Insertion Loss & Return Loss VS Frequency (T_A=25°C)



Broadband Insertion Loss VS Frequency (T_A=25°C)



Recommended Assembly Diagrams



Application Notes:

- 1. The chip is back-metallized and can be die-mounted with AuSn eutectic preforms or with electrically conductive epoxy.
- 2. The die should be assembled on carriers like Kovar or Mu-Cu which have same Coefficient of thermal expansion. (5.8×10 -6/) with GaAs.
- 3. Recommend using $\Phi 25 \text{um}$ Au wire for bonding, whose length is around 400 um.
- 4. Sinter by AuSn (80/20), which doesn't exceed 300°C within 30 seconds max.
- $4. \ \$ Handle the chips in a clean environment. DO NOT attempt to clean the chip using liquid cleaning systems.
- 5. Handle the chip along the edges with a vacuum collet or with a sharp pair of bent tweezers.
- 6. The device is sensitive to ESD. ESD protection is required during storage and usage.
- 7. If you have any questions, please contact us.